Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/855,511	CHEN ET AL.		
Examiner	Art Unit		
lana N Le	2685		

	SEARCHED			
Class	Subclass	Date	Examiner	
455	127.1	7/26/2005	L.L.	
	127.2	,		
	127.3			
	115.1			
	115.3			
	115.4			
	343.1			
	343.2			
	343.5			
455	127.5			

INTERFERENCE SEARCHED						
Cla	ıss	Subclass		Date	Ex	aminer
45	55	127.1	7/2	6/2005		L.L.
		127.3			-	
		343.1				
330		115.1 51				

SEARC (INCLUDING SE	H NOT	ES STRATEGY)
		DATE	EXMR
East-subclasses -keywords		7/26/2005	L.L.
consulted with: Vo, Nguyen		7/26/2005	L.L.